

Masahiro Hori

List of Publications by Year in descending order

Source: <https://exaly.com/author-pdf/9858443/publications.pdf>

Version: 2024-02-01

11

papers

77

citations

1684188

5

h-index

1720034

7

g-index

11

all docs

11

docs citations

11

times ranked

60

citing authors

#	ARTICLE	IF	CITATIONS
1	Detection of arsenic donor electrons using gate-pulse-induced spin-dependent recombination in silicon transistors. <i>Applied Physics Letters</i> , 2021, 118, 263504.	3.3	0
2	Critical conductance of two-dimensional electron gas in silicon-on-insulator metal-oxide-semiconductor field-effect transistor. <i>Applied Physics Express</i> , 2021, 14, 104003. <small>Charge Pumping Under Spin Resonance In <i>silicon-math</i></small>	2.4	0
3	<small>xmlNs:mml="http://www.w3.org/1998/Math/MathML" display="inline"</small> overflow="scroll">><mml:mi>Si</mml:mi><mml:mo>stretchy="false">(</mml:mo><mml:mn>100</mml:mn><mml:mo>Tj ETQq1 1 0.784314 rgBT /Overlock 10 Tf 50 652 Td (stretchy="false")		
4	<small>Applied, 2019, 11, .</small> Electron aspirator using electronâ€“electron scattering in nanoscale silicon. <i>Nature Communications</i> , 2018, 9, 4813.	12.8	5
5	Detection and Characterization of Single Near-Interface Oxide Traps with the Charge Pumping Method. , 2018, , .		0
6	Single-electron quantization at room temperature in a-few-donor quantum dot in silicon nano-transistors. <i>Applied Physics Letters</i> , 2017, 110, .	3.3	22
7	Improvement of charge-pumping electrically detected magnetic resonance and its application to silicon metalâ€“oxideâ€“semiconductor field-effect transistor. <i>Applied Physics Express</i> , 2017, 10, 015701.	2.4	5
8	Charge pumping EDMR towards charge/spin manipulation in silicon at room temperature. , 2016, , .		0
9	Electrical activation and electron spin resonance measurements of arsenic implanted in silicon. <i>Applied Physics Letters</i> , 2015, 106, 142105.	3.3	5
10	Direct observation of electron emission and recombination processes by time domain measurements of charge pumping current. <i>Applied Physics Letters</i> , 2015, 106, .	3.3	10
11	Analysis of electron capture process in charge pumping sequence using time domain measurements. <i>Applied Physics Letters</i> , 2014, 105, 261602.	3.3	17